

Notice of References Cited

Application/Control No.

10/559,864

Applicant(s)/Patent Under
Reexamination
HAIK-BERAUD ET AL.

Examiner

Ngoc-Yen M. Nguyen

Art Unit

1793

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,548,440	04-2003	Pham et al.	502/71
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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